



JC02 Rec'd PCT/PTO 16 JUN 2005 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

International Application of

Confirmation No.: 9106

Harumatsu MIURA et al

Art Unit: 1742

US S. N. 10/529,587

Examiner:

International application SN: PCT/JP2003/012530

US Filing Date: March 29, 2005

International filing Date: 30 Sept 2003

For: HIGH HARD, STRENGTH AND TOUGH NANO-CRYSTAL METAL BULK MATERIAL, AND ITS PREPARATION PROCESS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

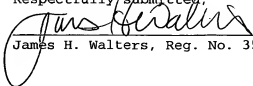
Sir:

Applicants wish to draw attention to the documents listed on the accompanying Form PTO-1449, copies of which documents are enclosed for any non-U.S. patent/application citations.

Pursuant to MPEP 609, it is requested that the Examiner should initial Form PTO-1449 to confirm that each document has been considered, and return a copy of the form to the undersigned.

The documents were cited in the International Phase, and pursuant to MPEP 609 A(3), it is believed that the indication of relevance of the documents given in the International Search Report satisfies the requirement in 37 CFR 1.98(a)(3) for a concise explanation of relevance with respect to the non-English documents.

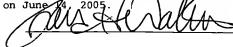
Respectfully submitted,

  
James H. Walters, Reg. No. 35,731

Customer number 802  
DELLETT AND WALTERS  
P.O. Box 2786  
Portland, Oregon 97208-2786 US  
(503) 224-0115  
DOCKET: T-1427

Certificate of Mailing

I hereby certify that this correspondence is being deposited as first class mail with the United States Postal Service in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on June 16, 2005.



<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				ATTY DOCKET NO. <b>T-1427</b>		APPLICATION NO. <b>10/529,587</b>	
				APPLICANT(S) <b>Harumatsu MIURA et al</b>			
FILING DATE <b>3/29/2005</b>				GROUP ART UNIT <b>1793 1742</b>			

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
/n.m./	4909840	3/20/1990	Schlump				

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	

FOREIGN PATENT DOCUMENTS							
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
					YES	NO	
/n.m./ 10-88289	4/7/1998	Japan			Abstract	✓	
/n.m./ 11-43748	2/16/1999	Japan			Abstract	✓	
/n.m./ 1234894	8/28/2002	EP				✓	
/n.m./ 5-117716	5/14/1993	Japan				✓	
/n.m./ 2001-207202	7/31/2001	Japan			Abstract	✓	

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>			

EXAMINER /Ngodan Mai/	DATE CONSIDERED 02/20/2008
--------------------------	-------------------------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>	ATTY DOCKET NO. <b>T-1427</b>	APPLICATION NO. <b>10/529,587</b>
	APPLICANT(S) <b>Harumatsu MIURA et al</b>	
	FILING DATE <b>3/29/2005</b>	GROUP ART UNIT <b>1795 1742</b>

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/n.m./		2002-206102	7/26/2002	Japan				✓

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>			

EXAMINER /Ngoclan Mai/	DATE CONSIDERED 02/20/2008
---------------------------	-------------------------------

\*EXAMINER. Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.